



# ESDA6V1M6, ESDA6V1-5M6

## 4- and 5-line Transil™ arrays for ESD protection

### Features

- High ESD protection level
- High integration
- Suitable for high density boards
- 4 unidirectional Transil diodes (ESDA6V1M6)
- 5 unidirectional Transil diodes (ESDA6V1-5M6)
- Breakdown Voltage  $V_{BR} = 6.1 \text{ V min}$
- High peak power dissipation: 100 Watts 8/20  $\mu\text{s}$
- Low leakage current  $< 500 \text{ nA}$
- Low diode capacitance (70 pF typ at 0 V)
- Very small PCB area: 1.45 mm<sup>2</sup>
- 500 microns pitch
- Lead-free package

### Complies with the following standards:

- IEC 61000-4-2
  - 15 kV (air discharge)
  - 8 kV (contact discharge)
- MIL STD 883G- Method 3015-7: class 3B
  - $> 8 \text{ kV}$  (human body model)

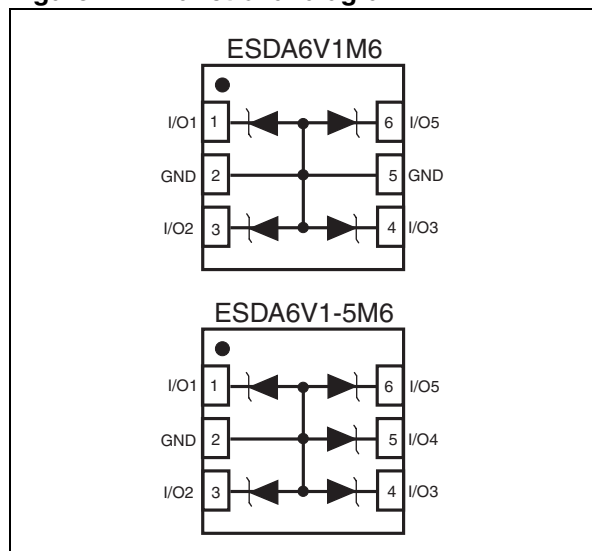
### Applications

Where transient overvoltage protection in ESD sensitive equipment is required, such as:

- Computers
- Printers
- Communication systems
- Cellular phone handsets and accessories
- Video equipment



Figure 1. Functional diagram



### Description

The ESDA6V1xxM6 are monolithic arrays designed to protect up to 4 or 5 lines against ESD transients.

The device is ideal for applications where both reduced print circuit board space and power absorption capability are required.

TM: Transil is a trademark of STMicroelectronics

# 1 Characteristics

**Table 1. Absolute maximum ratings ( $T_{amb} = 25\text{ °C}$ )**

Symbol	Parameter	Value	Unit
$V_{PP}$	ESD IEC 61000-4-2, air discharge	$\pm 15$	kV
	ESD IEC 61000-4-2, contact discharge	$\pm 11$	
	MIL STD 883G- Method 3015-7: class 3B, (human body model)	25	
$P_{PP}$	Peak pulse power dissipation (8/20 $\mu$ s) <sup>(1)</sup>   $T_j$ initial = $T_{amb}$	100	W
$I_{pp}$	Repetitive peak pulse current typical value (8/20 $\mu$ s)	8	A
$T_j$	Junction temperature	125	$^{\circ}\text{C}$
$T_{stg}$	Storage temperature range	-55 to +150	$^{\circ}\text{C}$
$T_L$	Maximum lead temperature for soldering during 10 s at 5 mm for case	260	$^{\circ}\text{C}$
$T_{OP}$	Operating temperature range	-40 to +125	$^{\circ}\text{C}$

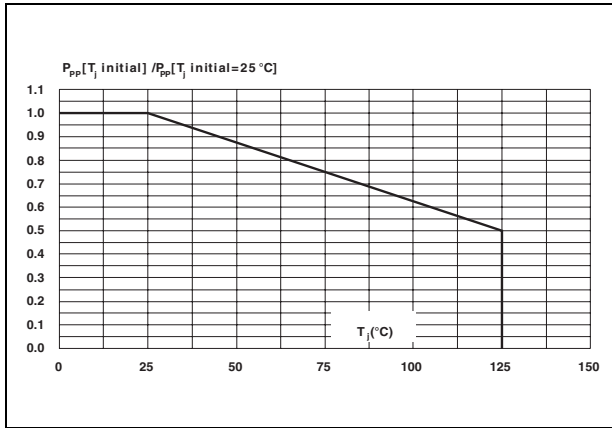
1. For a surge greater than the maximum values, the diode will fail in short-circuit.

**Table 2. Electrical characteristics ( $T_{amb} = 25\text{ °C}$ )**

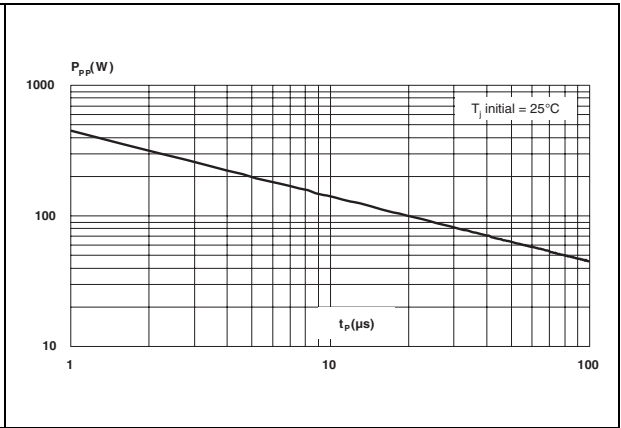
Symbol	Parameter				
$V_{RM}$	Stand-off voltage				
$V_{BR}$	Breakdown voltage				
$V_{CL}$	Clamping voltage				
$I_{RM}$	Leakage current @ $V_{RM}$				
$I_{PP}$	Peak pulse current				
$\alpha T$	Voltage temperature coefficient				
$V_F$	Forward voltage drop				
$I_{RM}$	Leakage current @ $V_{RM}$				
$V_{BR}$	$I_R = 1\text{ mA}$	6.1		7.2	V
$I_{RM}$	$V_{RM} = 3\text{ V}$			500	nA
$V_F$	$I_F = 10\text{ mA}$			1	V
$R_d$			1		$\Omega$
$\alpha T^{(1)}$	$I_R = 1\text{ mA}$			5	$10^{-4}/^{\circ}\text{C}$
C	$V_R = 0\text{ V DC}$ , $F = 1\text{ MHz}$ , $V_{osc} = 30\text{ mV}_{RMS}$		70		pF

1.  $\Delta V_{BR} = \alpha T * (T_{amb} - 25\text{ °C}) * V_{BR}(25\text{ °C})$

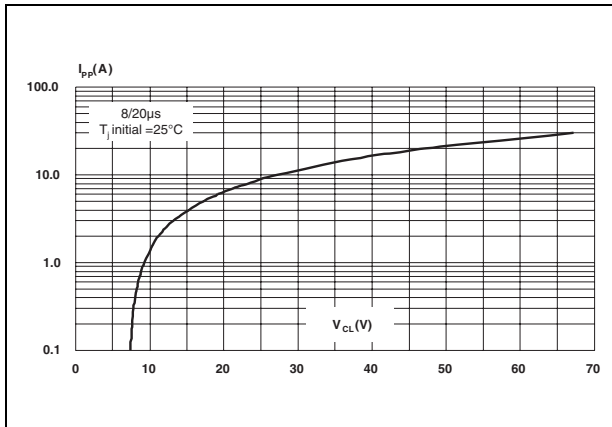
**Figure 2. Relative variation of peak pulse power versus initial junction temperature**



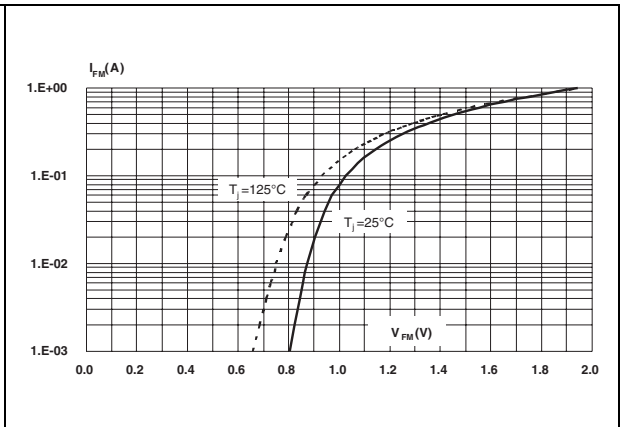
**Figure 3. Peak pulse power versus exponential pulse duration**



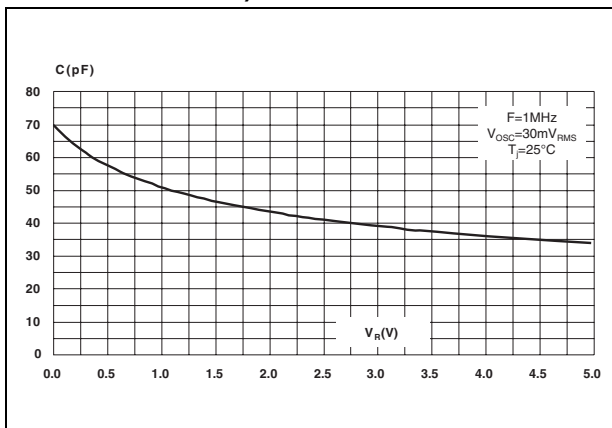
**Figure 4. Clamping voltage versus peak pulse current (typical values, 8/20 µs waveform)**



**Figure 5. Forward voltage drop versus peak forward current (typical values)**



**Figure 6. Junction capacitance versus reverse voltage applied (typical values)**



**Figure 7. Relative variation of leakage current versus junction temperature (typical values)**

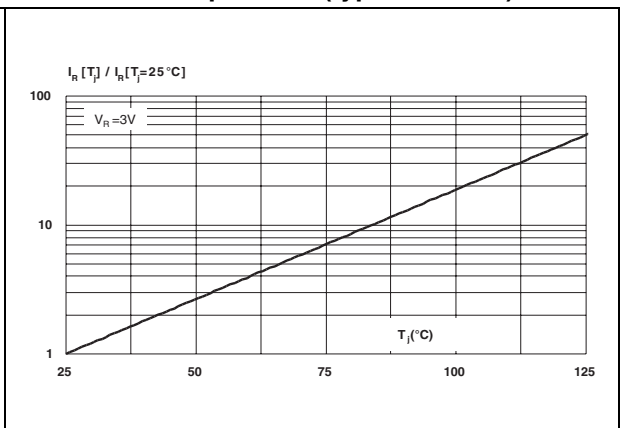


Figure 8. S21 attenuation measurement results of each channel

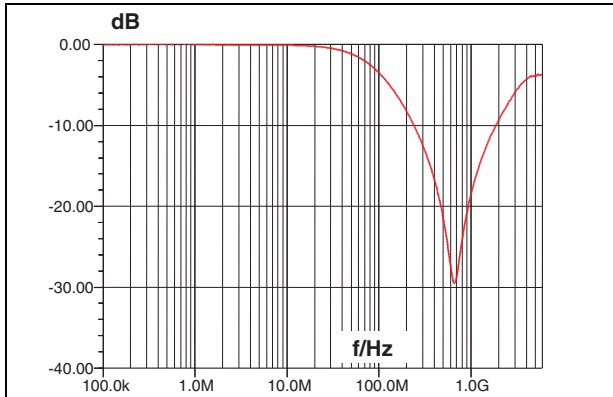


Figure 9. Analog crosstalk measurements between channels

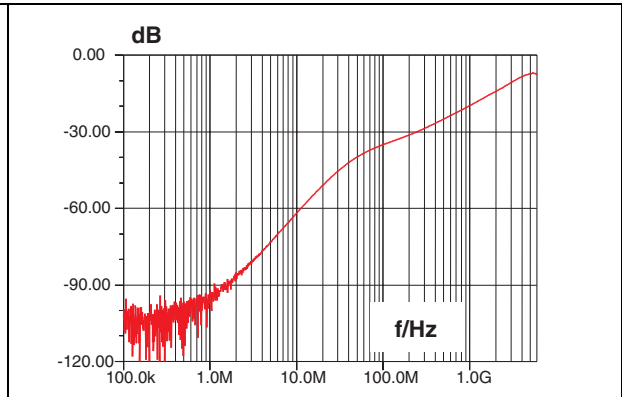


Figure 10. ESD response to IEC 6100-4-2 (+15 kV air discharge) on each channel

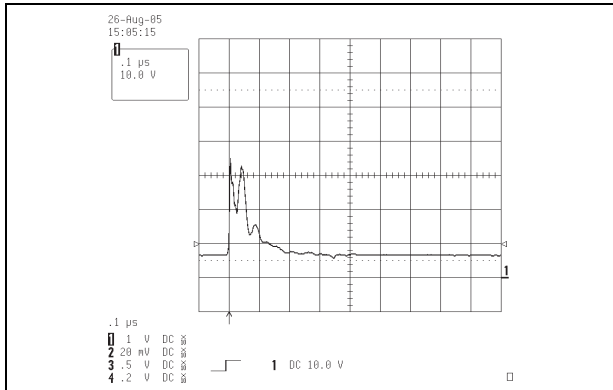
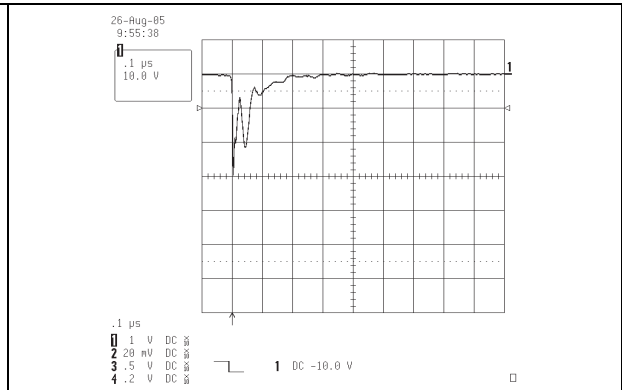
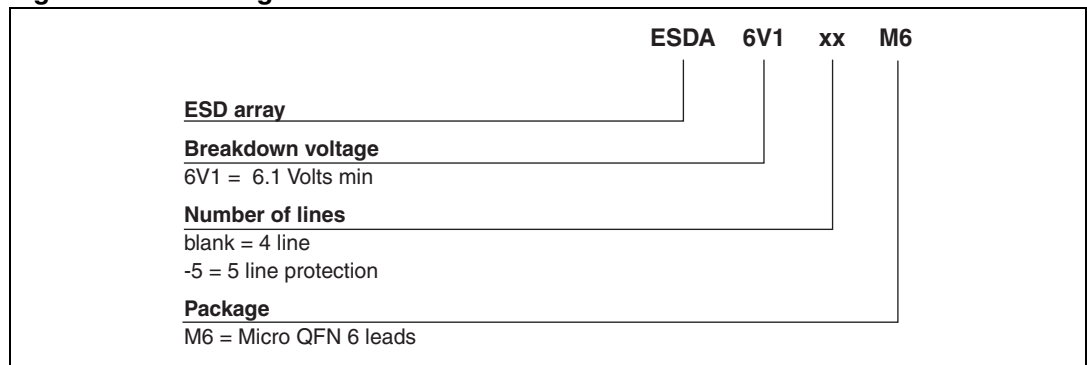


Figure 11. ESD response to IEC 6100-4-2 (-15 kV air discharge) on each channel



## 2 Ordering information scheme

Figure 12. Ordering information scheme



### 3 Package information

- Epoxy meets UL94, V0

In order to meet environmental requirements, ST offers these devices in ECOPACK® packages. These packages have a lead-free second level interconnect. The category of second level interconnect is marked on the inner box label, in compliance with JEDEC Standard JESD97. The maximum ratings related to soldering conditions are also marked on the inner box label. ECOPACK is an ST trademark. ECOPACK specifications are available at [www.st.com](http://www.st.com).

**Table 3. Package dimensions**

Ref	Dimensions					
	Millimeters			Inches		
	Min	Typ	Max	Min	Typ	Max
A	0.50	0.55	0.60	0.020	0.022	0.024
A1	0.00	0.02	0.05	0.000	0.001	0.002
b	0.18	0.25	0.30	0.007	0.010	0.012
D <sup>(1)</sup>		1.45			0.057	
E <sup>(1)</sup>		1.00			0.039	
e <sup>(2)</sup>		0.50			0.020	
k	0.20			0.008		
L	0.30	0.35	0.40	0.012	0.014	0.016

- ± 0.1 mm
- ± 0.05 mm

**Figure 13. Footprint dimensions in mm [inches]**

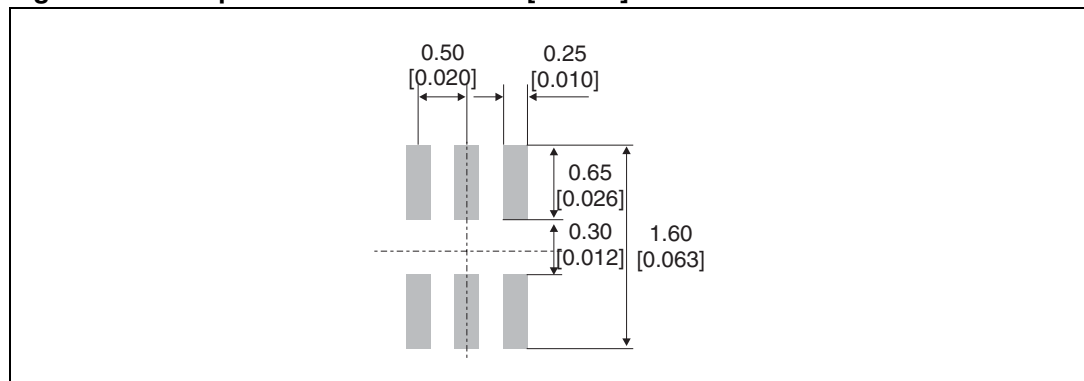
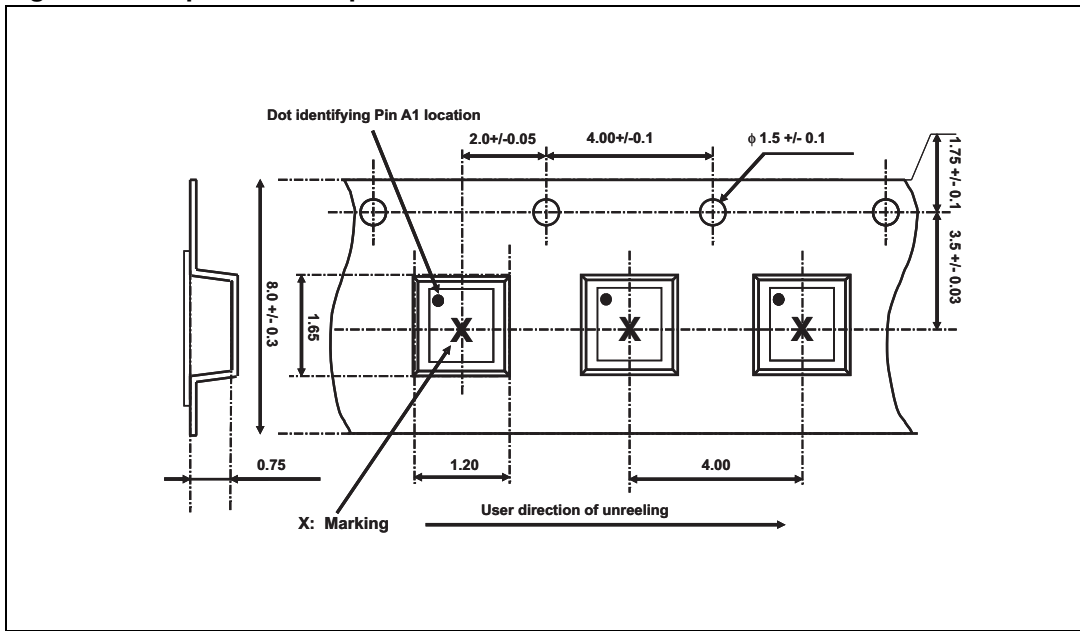


Figure 14. Tape and reel specification



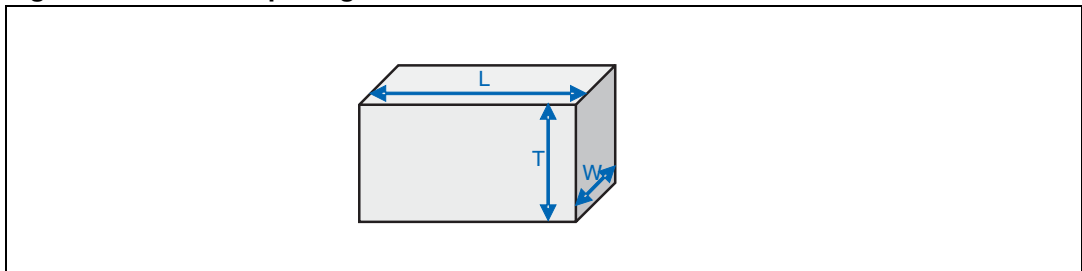
Note: Product marking may be rotated by 90° for assembly plant differentiation. In no case should this product marking be used to orient the component for its placement on a PCB. Only pin 1 mark is to be used for this purpose.

## 4 Recommendation on PCB assembly

### 4.1 Stencil opening design

1. General recommendation on stencil opening design
  - a) Stencil opening dimensions: L (Length), W (Width), T (Thickness).

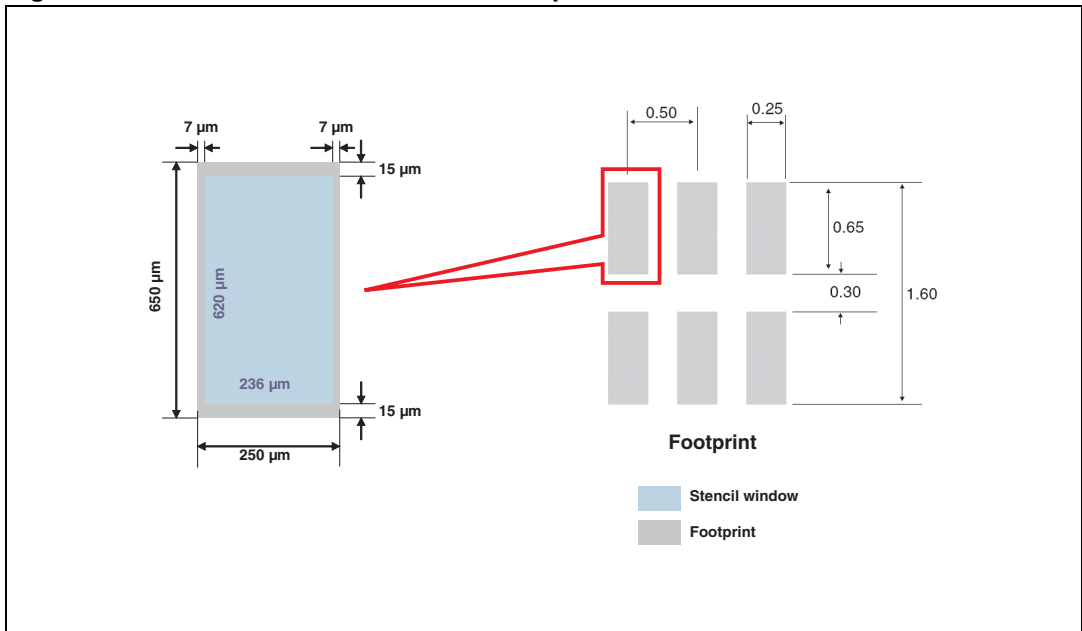
**Figure 15. Stencil opening dimensions**



- b) General design rule
  - Stencil thickness (T) = 75 ~ 125 μm
  - Aspect Ratio =  $\frac{W}{T} \geq 1.5$
  - Aspect Area =  $\frac{L \times W}{2T(L + W)} \geq 0.66$

2. Reference design
  - a) Stencil opening thickness: 100 μm
  - b) Stencil opening for leads: Opening to footprint ratio is 90%.

**Figure 16. Recommended stencil window position**



## 4.2 Solder paste

1. Halide-free flux qualification ROL0 according to ANSI/J-STD-004.
2. “No clean” solder paste is recommended.
3. Offers a high tack force to resist component movement during high speed.
4. Solder paste with fine particles: powder particle size is 20-45  $\mu\text{m}$ .

## 4.3 Placement

1. Manual positioning is not recommended.
2. It is recommended to use the lead recognition capabilities of the placement system, not the outline centering.
3. Standard tolerance of  $\pm 0.05$  mm is recommended.
4. 3.5 N placement force is recommended. Too much placement force can lead to squeezed out solder paste and cause solder joints to short. Too low placement force can lead to insufficient contact between package and solder paste that could cause open solder joints or badly centered packages.
5. To improve the package placement accuracy, a bottom side optical control should be performed with a high resolution tool.
6. For assembly, a perfect supporting of the PCB (all the more on flexible PCB) is recommended during solder paste printing, pick and place and reflow soldering by using optimized tools.

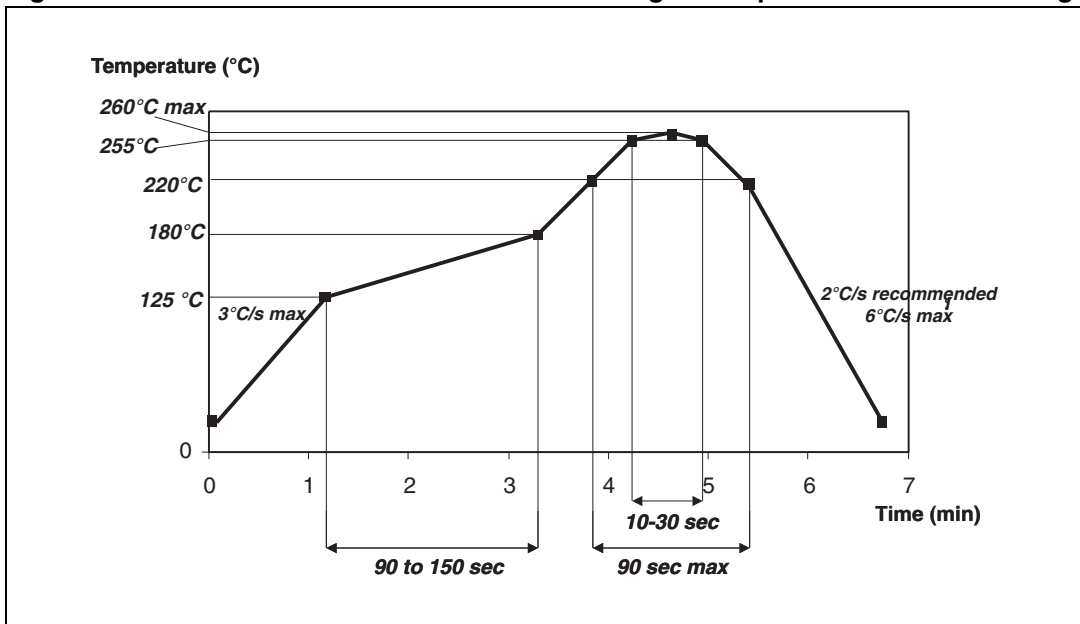
## 4.4 PCB design preference

1. To control the solder paste amount, the closed via is recommended instead of open vias.
2. The position of tracks and open vias in the solder area should be well balanced. The symmetrical layout is recommended, in case any tilt phenomena caused by asymmetrical solder paste amount due to the solder flow away.



### 4.5 Reflow profile

Figure 17. ST ECOPACK® recommended soldering reflow profile for PCB mounting



Note: Minimize air convection currents in the reflow oven to avoid component movement.

## 5 Ordering information

**Table 4. Ordering information**

Order code	Marking	Package	Weight	Base qty	Delivery mode
ESDA6V1M6	I <sup>(1)</sup>	Micro QFN	2.2 mg	3000	Tape and reel
ESDA6V1-5M6	J <sup>(1)</sup>	Micro QFN	2.2 mg	3000	Tape and reel

1. The marking can be rotated by 90° to differentiate assembly location

## 6 Revision history

**Table 5. Document revision history**

Date	Revision	Changes
19-Sep-2005	1	Initial release.
10-Oct-2005	2	Package title changed from DFN to QFN. No technical changes.
01-Feb-2007	3	Reformatted to current standard. Added note on marking rotation in section 3. Package information.
18-Feb-2008	4	Reformatted to current standards. Corrected inch measurements in <a href="#">Table 3 on page 5</a> . Added <a href="#">Section 4: Recommendation on PCB assembly</a> .

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